

Notice of References Cited

Application/Control No.

09/774,555

Applicant(s)/Patent Under
Reexamination
DELONG ET AL.

Examiner

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Art Unit

1616

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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X	N	WO 99/12895	03-1999	WO	Wos et al.	
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